

Total Dose Test Multiplexer HCF 4053 BM1 SMD Manufactured by SGS Thomson

G. Krein (krein@vh-s.de) von Hoerner & Sulger GmbH (www.vh-s.de) Schlossplatz 8, D-68723 Schwetzingen, Germany

06 April 2000

1 Tested Devices

• Triple 2-channel analog multiplexer, HCF 4053 BM1 from SGS Thomson

• Temperature range: $-40^{\circ}\text{C}...+85^{\circ}\text{C}$

• Package: 16-lead plastic SOIC (Suffix M1)

 \bullet Package marks: HCF 4053 ST, 90G927

• SGS Thomson data sheet: June 1989

• vH&S order 004474-SESAME-Zi/00

1.1 Device Marking

Six devices irradiated; two devices for reference. Only one device per total dose step is tested.

| Mark | Total Dose | |
|-----------------|---|-------------|
| 0K/1 | $0\mathrm{kRad}\;\mathrm{H_2O}$ | (reference) |
| 0K/2 | $0\mathrm{kRad}\mathrm{H}_2\mathrm{O}$ | (reference) |
| $5\mathrm{K}/1$ | $5\mathrm{kRad}\;\mathrm{H_2O}$ | |
| 5K/2 | $5\mathrm{kRad}\;\mathrm{H_2O}$ | |
| 10K/1 | $10\mathrm{kRad}\;\mathrm{H_2O}$ | |
| 10K/2 | $10\mathrm{kRad}\;\mathrm{H_2O}$ | |
| 22K/1 | $22\mathrm{kRad}\mathrm{H}_2\mathrm{O}$ | |
| 22K/2 | $22\mathrm{kRad}\;\mathrm{H_2O}$ | |

vH&S GmbH 06 April 2000



Total Dose Test: HCF 4053 BM1 SMD

2 Radiation Facility

Radiation Facility at ESTEC, Noordwijk, The Netherlands.

| Date | 2 March 2000 | 3 March 2000 | 2 March 2000 | | |
|------------|--|---|---|--|--|
| Total Dose | $5 \mathrm{krad} \left(\mathrm{H_2O}\right)$ | $10 \mathrm{krad} \left(\mathrm{H_2O}\right)$ | $22 \mathrm{kRad} \left(\mathrm{H_2O}\right)$ | | |
| Log File | d:\data\vh-s5k.txt | d:\data\vh-s10k.txt | d:\data\vh-s15k.txt | | |
| Device | unbiased | | | | |
| Project | vH&S | | | | |
| Dosemeter | Farmer 2670 | | | | |
| Chamber | NE 0.6cc air ionisation type 2571 serial no. 2915 | | | | |
| Dose Rate | $24 \mathrm{rad/min} \left(\mathrm{H_2O} \right)$ | | | | |
| Test Eng. | Bob Nickson, QCA, ESTEC, Noordwijk | | | | |

All pins of all tested devices shorted during irradiation. No annealing was performed after irradiation.

3 Measured Device Parameters

- Currents $I_{\rm DD}$ and $I_{\rm EE}$ see section 4.
- $R_{\rm ON}$ see section 5.
- Threshold voltage $V_{\text{INL}} \leftrightarrow V_{\text{INH}}$ at EN input see section 6.

4 $I_{\rm DD}/I_{\rm EE}$ Test

Measurements done at 6 April 2000, vH&S.

4.1 Test Setup

Pins 6, 8 (V_{SS}), 9, 10, 11 connected to GND. Pin 1, 2, 3, 4, 5, 12, 13, 14, 15 floating between V_{DD} and V_{EE} . Pin 16 (V_{DD}) connected to +5 V. Pin 7 (V_{EE}) connected to -5 V.

4.2 Test Results

The current was measured with a digital multimeter. The current consumption of all devices were lower than $100\,\mathrm{nA}$. There was no current indicated by the digital multimeter.

5 $R_{\rm ON}$ Test

Measurements done at 6 April 2000, vH&S.

vH&S GmbH 06 April 2000



5.1 Test Setup

Pins 6, 8 (V_{SS}) , 9, 10, 11 connected to GND.

Pins 1, 2, 3, 12, 13, 14, 15 floating between $V_{\rm DD}$ and $V_{\rm EE}$.

Pin 5 connected to +4 V.

Pin 4 connected through $1 k\Omega$ to GND.

Pin 16 $(V_{\rm DD})$ connected to +5 V.

Pin 7 ($V_{\rm EE}$) connected to -5 V.

Resistance $R_{\rm ON}$ calculated by voltage drop over $1\,{\rm k}\Omega$ resistor.

5.2 Test Results

| Device | Total Dose | $R_{\rm ON}$ |
|--------|----------------------------------|-----------------|
| 0K/1 | $0\mathrm{kRad}\;\mathrm{H_2O}$ | $193,2\Omega$ |
| 10K/1 | $10\mathrm{kRad}\;\mathrm{H_2O}$ | $194,\!6\Omega$ |
| 22K/1 | $22\mathrm{kRad}\;\mathrm{H_2O}$ | $197,\!4\Omega$ |

6 $V_{\rm EN}$ Threshold Voltage Test

Measurements done at 6 April 2000, vH&S.

6.1 Test Setup

Pins 8 (V_{SS}) , 9, 10, 11 connected to GND.

Pins 1, 2, 3, 12, 13, 14, 15 floating between $V_{\rm DD}$ and $V_{\rm EE}$.

Pin 5 connected to +4 V.

Pin 4 connected through $50 \,\mathrm{k}\Omega$ to GND.

Pin 6 connected to a ajustable voltage source. Pin 16 (V_{DD}) connected to +5 V.

Pin 7 ($V_{\rm EE}$) connected to -5 V.

The voltage at Pin 6 was measured with a digital voltmeter.

6.2 Test Results

| Device | Total Dose | $V_{ m EN}$ | $V_{ m EN}$ |
|--------|---|---------------------|-----------------|
| | | EN=0 to $EN=1$ | EN=1 to $EN=0$ |
| 0K/1 | $0\mathrm{kRad}\;\mathrm{H_2O}$ | $2{,}346\mathrm{V}$ | 2,286 V |
| 10K/1 | $10\mathrm{kRad}\;\mathrm{H_2O}$ | $1{,}990{ m V}$ | $1{,}930{ m V}$ |
| 22K/1 | $22\mathrm{kRad}\mathrm{H}_2\mathrm{O}$ | $1,\!802{ m V}$ | $1,750{ m V}$ |

vH&S GmbH 06 April 2000